Issue Classification

/Wei Y. Zhen/

(Primary Examiner)

ORIGINAL

Application/Control	o. Applicant(s)/Patent Under Reexamination
1	' ' '
10656654	FOURNET ET AL.
Examiner	Art Unit
ANNA DENG	2191

INTERNATIONAL CLASSIFICATION

CLASS			SUBCLASS			CLAIMED						NON-CLAIMED				
717 133					G	0	6	F	9 / 44 (2006.01	.01)						
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CROSS REFERENCE(S)																
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)																
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/ANNA DENG/ 7/29/20087										Total Claims Allowed:						
(Assistant Examiner) (Date)				73							3					

7/30/08

(Date)

O.G. Print Claim(s)

1

O.G. Print Figure

2